

INTERNATIONAL STANDARD

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INTERNATIONAL SPECIAL COMMITTEE ON RADIO INTERFERENCE
COMITÉ INTERNATIONAL SPÉCIAL DES PERTURBATIONS RADIOÉLECTRIQUES

Industrial, scientific and medical equipment – Radio-frequency disturbance characteristics – Limits and methods of measurement

Appareils industriels, scientifiques et médicaux – Caractéristiques de perturbations radioélectriques – Limites et méthodes de mesure

CISPR 11:2015

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INTERNATIONAL SPECIAL COMMITTEE ON RADIO INTERFERENCE

INDUSTRIAL, SCIENTIFIC AND MEDICAL EQUIPMENT – RADIO-FREQUENCY DISTURBANCE CHARACTERISTICS – LIMITS AND METHODS OF MEASUREMENT

FOREWORD

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CISPR 11 edition 6.2 contains the sixth edition (2015-06) [documents CISPR/B/628/FDIS and CISPR/B/631/RVD], its amendment 1 (2016-06) [documents CISPR/B/627/CDV and CISPR/B/639A/RVC] and its amendment 2 (2019-01) [documents CIS/B/715A/FDIS and CIS/B/719/RVD].

In this Redline version, a vertical line in the margin shows where the technical content is modified by amendments 1 and 2. Additions are in green text, deletions are in strikethrough red text. A separate Final version with all changes accepted is available in this publication.

International Standard CISPR 11 has been prepared by CISPR Subcommittee B: Interference relating to industrial, scientific and medical radio-frequency apparatus, to other (heavy) industrial equipment, to overhead power lines, to high voltage equipment and to electric traction.

This sixth edition introduces and permits type testing on components of power electronic equipment, systems and installations. Its emission limits apply now to low voltage (LV) a.c. and d.c. power ports, irrespective of the direction of power transmission. Several limits were adapted to the practical test conditions found at test sites. They are also applicable now to power electronic ISM RF equipment used for wireless power transfer (WPT), for instant power supply and charging purposes. The limits in the range 1 GHz to 18 GHz apply now to CW-type disturbances and to fluctuating disturbances in a similar, uniform and technology-neutral way. For these measurements, two alternative methods of measurement are available, the traditional log-AV method and the new APD method.

For measurements at LV d.c. power ports of power electronic equipment, a modern implementation of the 150 Ω Delta-network specified in CISPR 16-1-2 has been made available.

This International Standard CISPR 11 has the status of a Product Family EMC standard in accordance with IEC Guide 107, *Electromagnetic compatibility – Guide to the drafting of electromagnetic compatibility publications* (2014).

This publication has been drafted in accordance with the ISO/IEC Directives, Part 2.

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The main content of this standard is based on CISPR Recommendation No. 39/2 given below:

RECOMMENDATION No. 39/2

**Limits and methods of measurement of electromagnetic disturbance characteristics
of industrial, scientific and medical (ISM) radio-frequency equipment**

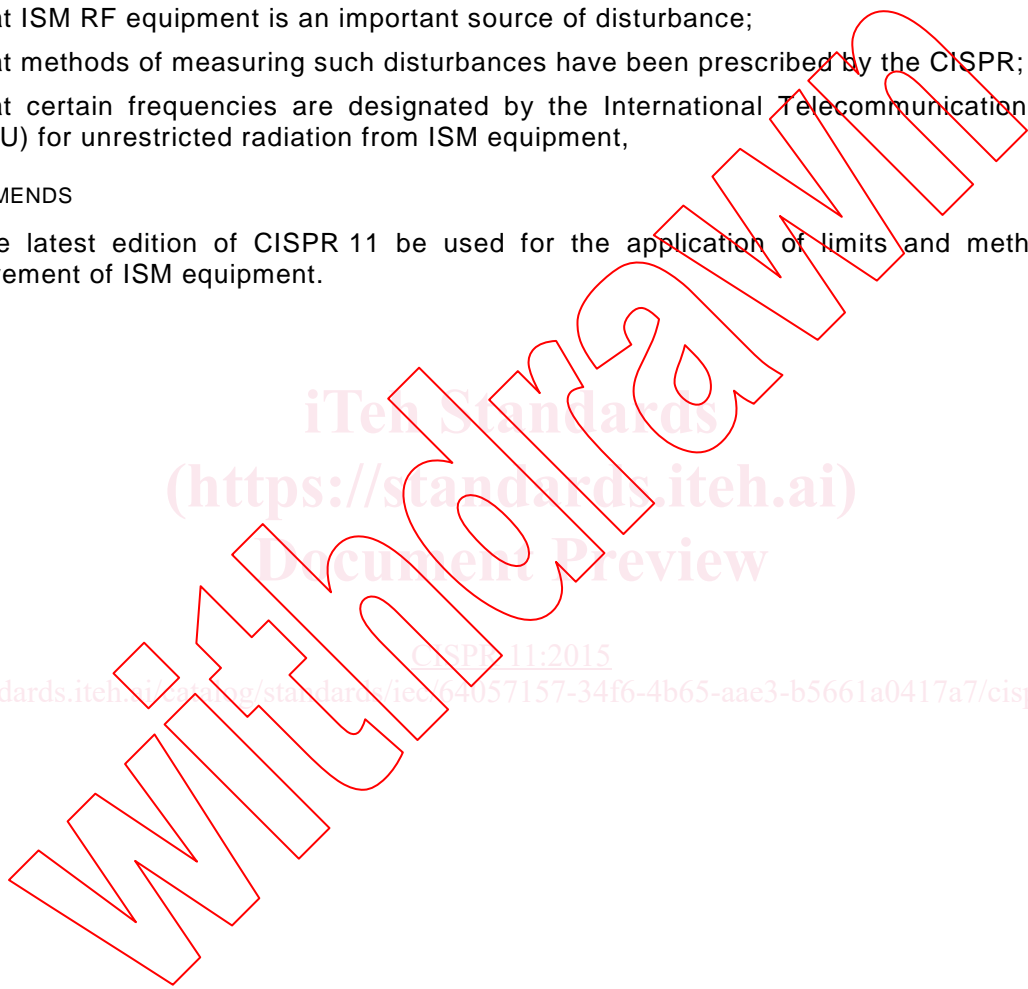
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CONSIDERING

- a) that ISM RF equipment is an important source of disturbance;
- b) that methods of measuring such disturbances have been prescribed by the CISPR;
- c) that certain frequencies are designated by the International Telecommunication Union (ITU) for unrestricted radiation from ISM equipment,

RECOMMENDS

that the latest edition of CISPR 11 be used for the application of limits and methods of measurement of ISM equipment.



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